

RF EXPOSURE REPORT

Applicant	Bellabeat,Inc.
Address	2 Mini Plaza, San Francisco, CA 94103,US

Manufacturer or Supplier	ellabeat,Inc.			
Address	/lini Plaza, San Francisco, CA 94103,US			
Product	nart Jewelry - Leaf Crystal			
Brand Name	llabeat			
Model	eaf Crystal Silver			
Additional Model & Model Difference	Leaf Crystal Rose Gold			
Date of tests	Jul. 09, 2019 ~ Aug. 15, 2019			

FCC Part 2 (Section 2.1093)

KDB 447498 D01

◯ IEEE C95.1

CONCLUSION: The submitted sample was found to **COMPLY** with the test requirement

Tested by Lucas Chen Project Engineer / EMC Department	Approved by Breeze Jiang Senior Project Engineer / EMC Department		
1			

Date: Aug. 30, 2019

This report is governed by, and incorporates by reference, CPS Conditions of Service as posted at the date of issuance of this report at http://www.bureauveritas.com/home/about-us/our-business/cps/about-us/terms-conditions/and is intended for your exclusive use. Any copying or replication of this report to or for any other person or entity, or use of our name or trademark, is permitted only with our prior written permission. This report sets forth our characteristics of the lot from which a test sample was taken or any similar or identical product unless specifically and expressly noted. Our report includes all of the tests requested by you and the results thereof based upon the information that you provided to us. Measurement uncertainty is only provided upon requiest for accredited tests. You have 60 days from date of issuance of this report to notify us of any material error or omission caused by our negligence or if you require measurement uncertainty; provided, however, that such notice shall be in writing and shall specifically address the issue you wish to raise. A failure to raise such issue within the prescribed time shall constitute you unqualified acceptance of the completeness of this report, the tests conducted and the correctness of the report contents.

Tel: +86 769 8998 2098 Fax: +86 769 8593 1080

Email: customerservice.dg@cn.bureauveritas.com



Table of Contents

RELE	ASE CONTROL RECORD	. 3
1.	CERTIFICATION	. 4
2.	RF EXPOSURE DEFINE	5
3.	CLASSIFICATION	5
4.	SAR TEST EXCLUSION THRESHOLDS	6

Tel: +86 769 8998 2098 Fax: +86 769 8593 1080

Email: customerservice.dg@cn.bureauveritas.com



RELEASE CONTROL RECORD

ISSUE NO. REASON FOR CHANGE		DATE ISSUED	
FM190709N054	Original release	Aug. 30, 2019	

No. 34, Chenwulu Section, Guantai Rd., Houjie Town, Dongguan City, Guangdong 523942, China

Fax: +86 769 8593 1080

Tel: +86 769 8998 2098

Email: customerservice.dg@cn.bureauveritas.com

Page 3 of 6 Report Version 1



1. CERTIFICATION

FCC ID:	2AELF-LF04			
PRODUCT:	Smart Jewelry - Leaf Crystal			
BRAND NAME:	Bellabeat			
MODEL NO.:	.: Leaf Crystal Silver			
ADDITIONAL NO.:	Leaf Crystal Rose Gold			
TEST SAMPLE:	Engineering Sample			
APPLICANT:	Bellabeat,Inc.			
STANDARDS:	FCC Part 2 (Section 2.1093)			
	KDB 447498 D01			
	IEEE C95.1			

Tel: +86 769 8998 2098 Fax: +86 769 8593 1080

Email: customerservice.dg@cn.bureauveritas.com



Test Report No.: FM190709N054

2. RF EXPOSURE DEFINE

The corresponding SAR Exclusion Threshold condition, listed below:

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR,16 where

- f(GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
- a) [Threshold at 50 mm in step 1) + (test separation distance 50 mm)-(f(MHz)/150)] mW, at 100MHz to 1500 MHz
- b) [Threshold at 50 mm in step 1) + (test separation distance 50 mm)·10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
 - a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(MHz))]$ for test separation distances > 50 mm and < 200 mm.
 - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by ½ for test separation distances ≤ 50 mm.
 - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

3. CLASSIFICATION

The antenna of this product, under normal use condition, is at less than 20cm away from the body of the user. So, this device is classified as **Portable Device**.



4. SAR TEST EXCLUSION THRESHOLDS

The tuned conducted Average Power (declared by client)

Mode	Frequency (MHz)	Target Power (dBm)	wer (dBm) Tolerance		Upper Tolerance (dBm)
GFSK	2402-2480	-7	+-2	-9	-5

The measured conducted Average Power

Mode	Mode Frequency (MHz)	
GFSK	2402	-7.58

SAR Test Exclusion Thresholds

Frequency (MHz)	Maximum source-based time averaged conducted output power (dBm)	Minimum separation distance (mm)	Result of Eq. 1	Limit for 1-g SAR	Limit for 10-g extremity SAR	Verdict
2402-2480	-5	5	0.09802	3.0	7.5	Exempt from SAR

Conclusion

Therefore this device complies with FCC's RF radiation exposure limits for general population without SAR evaluation.

Tel: +86 769 8998 2098 Fax: +86 769 8593 1080

Email: customerservice.dg@cn.bureauveritas.com

Page 6 of 6 Report Version 1